Notice of References Cited

Application/Control No.

10/803,640

Examiner

Long K. Tran

Applicant(s)/Patent Under
Reexamination
CHUNG ET AL.

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	4	US-5,195,018	03-1993	Kwon et al.	. 361/313
	В	US-2004/0077142	04-2004	Chao et al.	438/253
	O	US-2004/0155276	08-2004	lwasaki et al.	257/301
	D	US-2004/0262663	12-2004	Lin et al.	257/307
	Е	US-2003/0045048	03-2003	Marsh, Eugene P.	438/218
	F	US-2002/0115306	08-2002	Won et al.	438/781
	G	US-2004/0175882	09-2004	Ahn et al.	438/240
	Ι	US-6,472,319	10-2002	Won et al.	438/660
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			·

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	W	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.